SIGC15T60UN

High Speed IGBT Chip in NPT-technology

FEATURES:

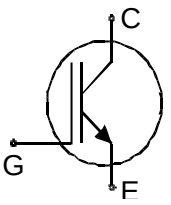
- **low Eoff**
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

This chip is used for:

- SGB15N60HS

Applications:

- Welding
- PFC
- UPS



Chip Type	V_{CE}	I_{Cn}	Die Size	Package	Ordering Code
SIGC15T60UN	600V	15A	3.2 x 4.55 mm^2	sawn on foil	Q67050-A4221-A101

MECHANICAL PARAMETER:

Raster size	3.2 x 4.55	mm^2
Area total / active	14.6 / 10.7	
Emitter pad size	2.2 x 1.7	
Gate pad size	1.1 x 0.696	
Thickness	100	µm
Wafer size	150	mm
Flat position	270	deg
Max.possible chips per wafer	1022	
Passivation frontside	Photoimide	
Emitter metallization	3200 nm Al Si 1%	
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	electrically conductive glue or solder	
Wire bond	Al, ≤500µm	
Reject Ink Dot Size	∅ 0.65mm ; max 1.2mm	
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C	

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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T_j=25 °C	V_{CE}	600	V
DC collector current, limited by T_{jmax}	I_C	1)	A
Pulsed collector current, t_p limited by T_{jmax}	I_{cpuls}	45	A
Gate emitter voltage	V_{GE}	±20	V
Operating junction and storage temperature	T_j, T_{stg}	-55 ... +150	°C

1) depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j=25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE}=0V, I_C=500µA	600			V
Collector-emitter saturation voltage	$V_{CE(sat)}$	V_{GE}=15V, I_C=15A		2.8	3.15	
Gate-emitter threshold voltage	$V_{GE(th)}$	I_C=400µA, V_{GE}=V_{CE}	3	4	5	
Zero gate voltage collector current	I_{CES}	V_{CE}=600V, V_{GE}=0V			1.2	µA
Gate-emitter leakage current	I_{GES}	V_{CE}=0V, V_{GE}=20V			100	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	C_{iss}	V_{CE}=25V V_{GE}=0V f=1MHz	-	810		pF
Output capacitance	C_{oss}		-	83		
Reverse transfer capacitance	C_{rss}		-	51		

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

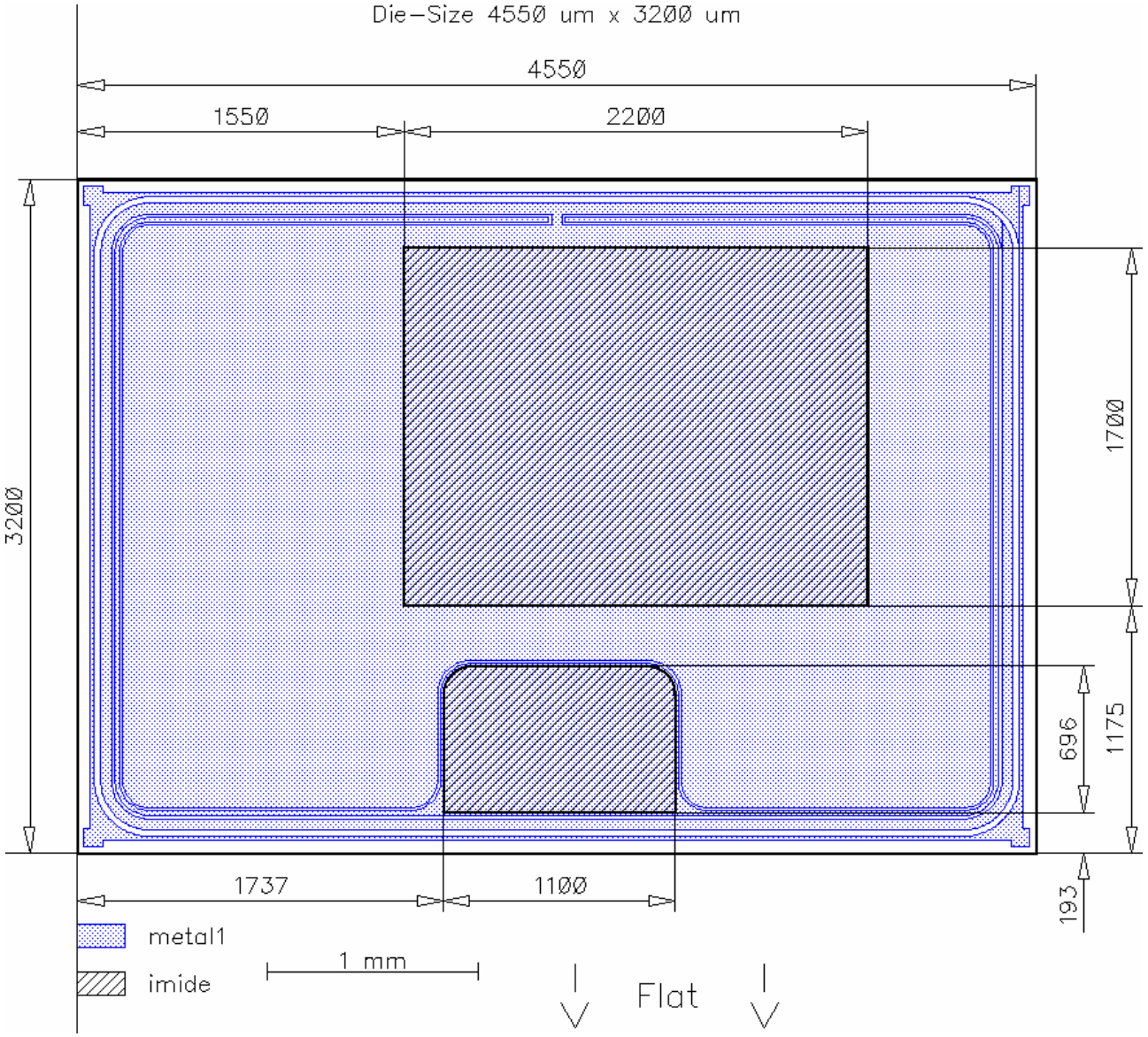
Parameter	Symbol	Conditions 1)	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	T_j=150°C V_{CC}=400V I_C=15A V_{GE}=+15/0V R_G=3.6Ω	-	11		ns
Rise time	t_r		-	6		
Turn-off delay time	$t_{d(off)}$		-	72		
Fall time	t_f		-	26		

1) values also influenced by parasitic L- and C- in measurement and package.

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CHIP DRAWING:



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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	SGB15N60HS	Package :TO220

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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